TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

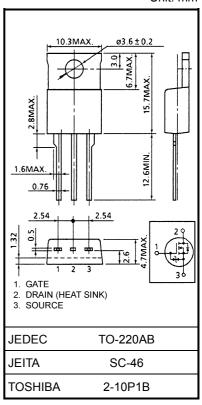
2SK2844

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- 4 V gate drive
- Low drain-source ON resistance $: R_{DS} (ON) = 16 \text{ m}\Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 26 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 30 \ V)$
- Enhancement-mode : $V_{th} = 0.8 \sim 2.0 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	30	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	35	А	
	Pulse (Note 1)	I _{DP}	140	А	
Drain power dissipatio	n (Tc = 25°C)	PD	60	W	
Single pulse avalanche energy (Note 2)		E _{AS}	259	mJ	
Avalanche current		I _{AR}	35	А	
Repetitive avalanche energy (Note 3)		E _{AR}	6	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 2.0 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	2.08	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	83.3	°C / W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 152 µH, R_G = 25 Ω , I_{AR} = 35 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution. Unit: mm

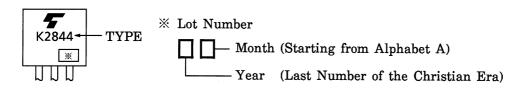
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA	
Drain cut-off cu	rrent	IDSS	V _{DS} = 30 V, V _{GS} = 0 V	_	_	100	μA	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	30	_	_	V	
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 18 A	_	26	35	mΩ	
			V _{GS} = 10 V, I _D = 18 A		16	20		
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 18 A	13	26	_	S	
Input capacitance	e	C _{iss}			980	_	pF	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		270	_		
Output capacitance		Coss			580	_		
Switching time	Rise time	tr	$V_{GS} \xrightarrow{10V}_{0V} \prod_{I_D = 18A \\ \downarrow $		14	_	- ns	
	Turn-on time	t _{on}		_	23	_		
	Fall time	t _f		_	64	_		
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w = 10 μ s	_	190	_		
Total gate charge (gate-source plus gate-drain)		Qg		_	40	_		
Gate-source charge		Q _{gs}	V _{DD} ≈ 24 V, V _{GS} = 10 V, I _D = 35 A -		32		nC	
Gate-drain ("miller") Charge		Q _{gd}			8	_		

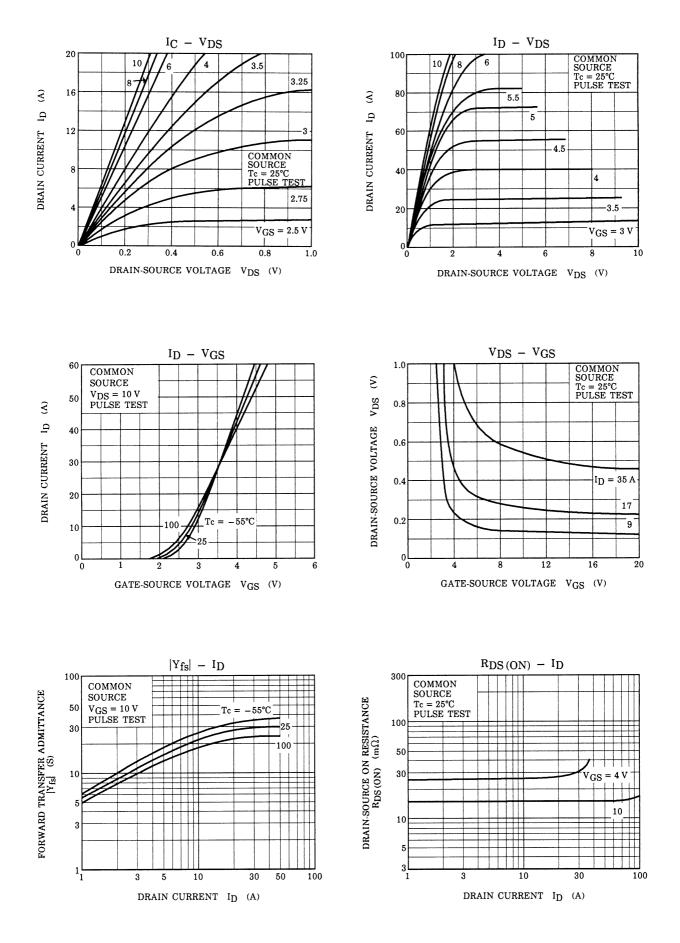
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	50	A
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	200	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 35 A, V _{GS} = 0 V	_	—	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 35 A, V _{GS} = 0 V, dI _{DR} / dt = 50 A / μs	_	120	_	ns
Reverse recovery charge	Q _{rr}		_	180	_	nC

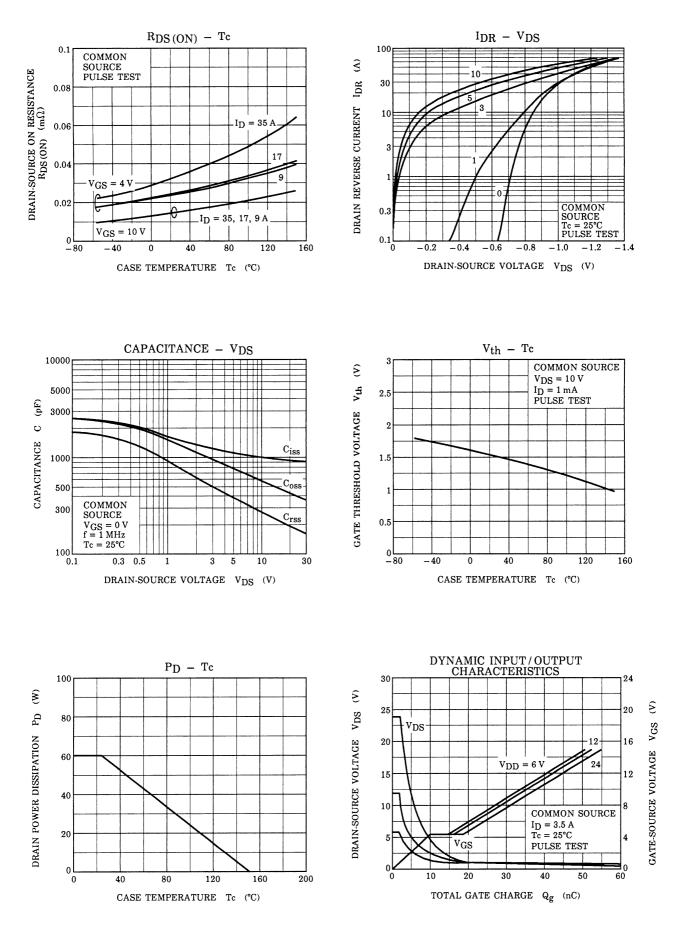
Marking

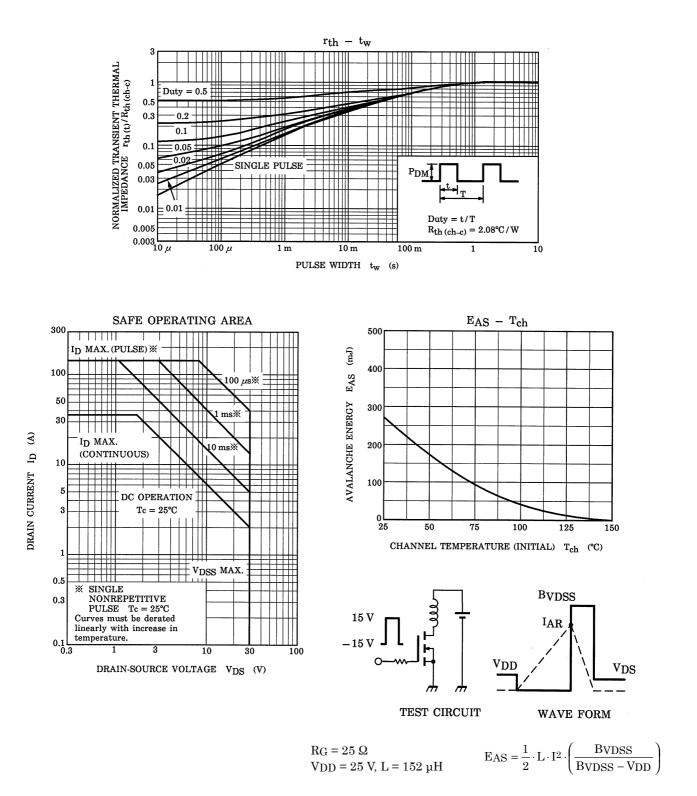


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